

# 2SC5703

High-Speed Switching Applications  
 DC-DC Converter Applications  
 Strobe Applications

- High DC current gain:  $h_{FE} = 400$  to  $1000$  ( $I_C = 0.5$  A)
- Low collector-emitter saturation voltage:  $V_{CE(sat)} = 0.12$  V (max)
- High-speed switching:  $t_f = 55$  ns (typ.)

### Absolute Maximum Ratings ( $T_a = 25^\circ\text{C}$ )

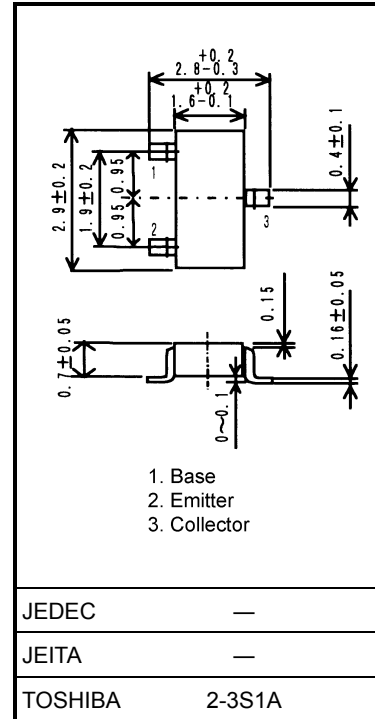
Characteristics		Symbol	Rating	Unit
Collector-base voltage		$V_{CBO}$	100	V
Collector-emitter voltage		$V_{CEX}$	80	V
Collector-emitter voltage		$V_{CEO}$	50	V
Emitter-base voltage		$V_{EBO}$	7	V
Collector current	DC	$I_C$	4	A
	Pulse	$I_{CP}$	7	
Base current		$I_B$	400	mA
Collector power dissipation	DC	$P_C$	800	mW
	$t = 10$ s	(Note 1)	1250	
Junction temperature		$T_j$	150	$^\circ\text{C}$
Storage temperature range		$T_{stg}$	-55 to 150	$^\circ\text{C}$

Note 1: Mounted on an FR4 board (glass epoxy, 1.6 mm thick, Cu area: 645 mm<sup>2</sup>)

Note 2: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

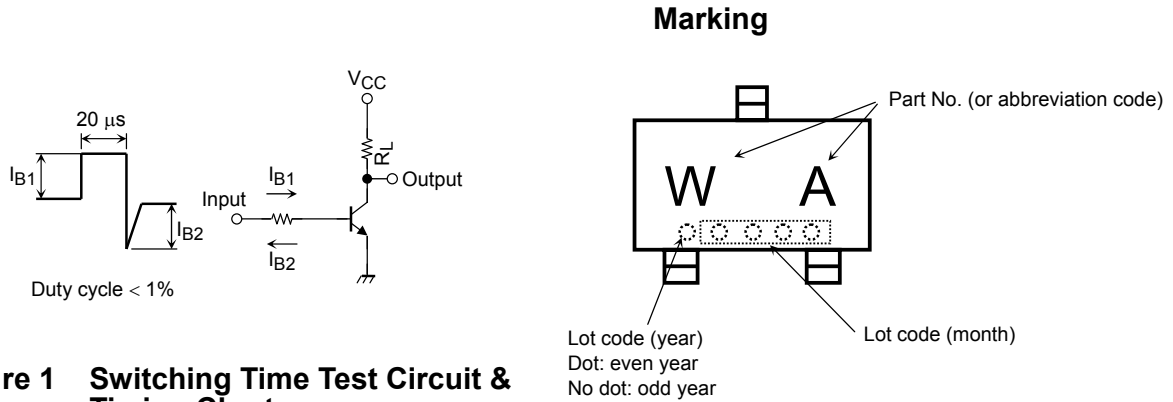
Unit: mm



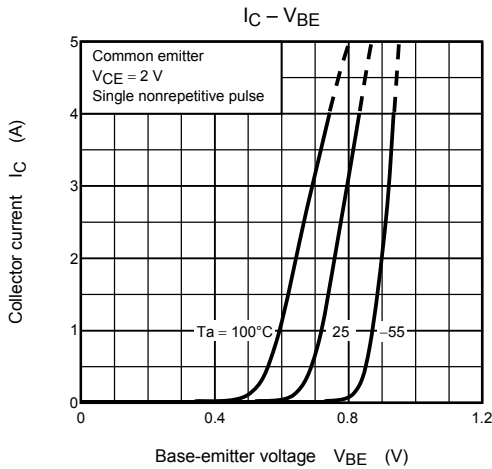
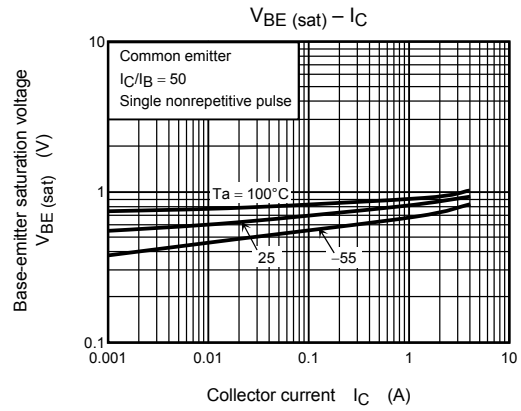
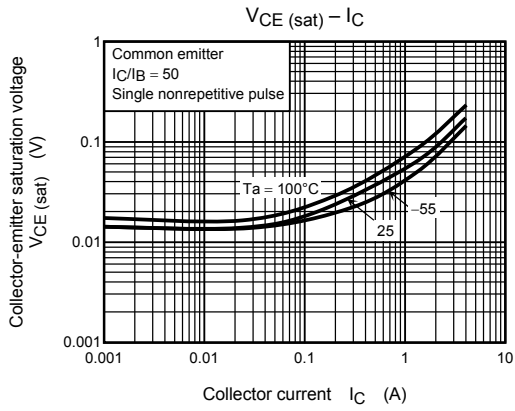
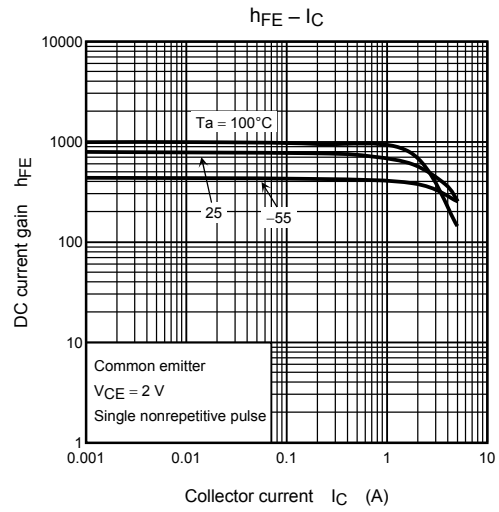
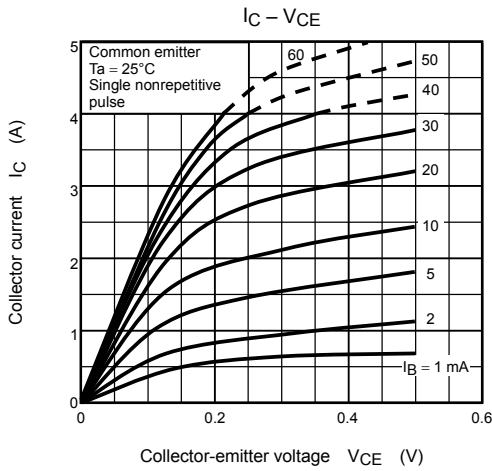
Weight: 0.01 g (typ.)

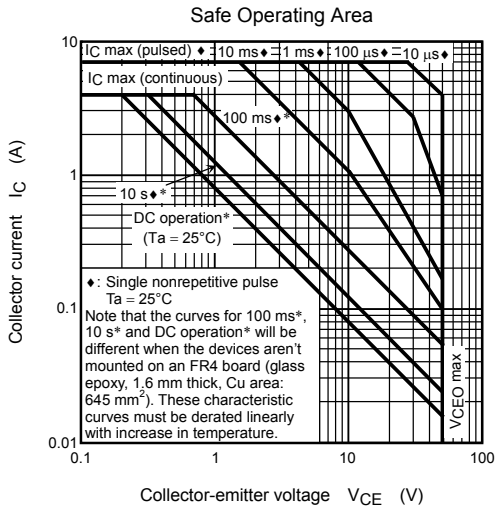
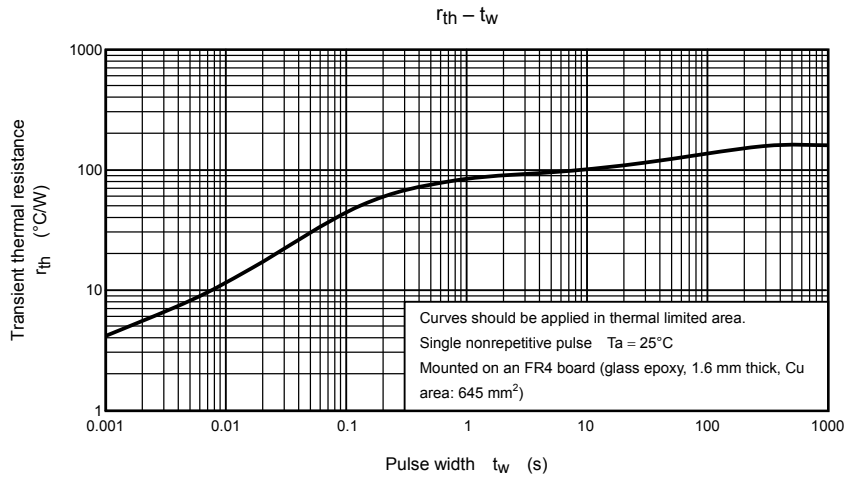
**Electrical Characteristics (Ta = 25°C)**

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit	
Collector cut-off current	$I_{CBO}$	$V_{CB} = 100\text{ V}, I_E = 0$	—	—	100	nA	
Emitter cut-off current	$I_{EBO}$	$V_{EB} = 7\text{ V}, I_C = 0$	—	—	100	nA	
Collector-emitter breakdown voltage	$V_{(BR) CEO}$	$I_C = 10\text{ mA}, I_B = 0$	50	—	—	V	
DC current gain	$h_{FE} (1)$	$V_{CE} = 2\text{ V}, I_C = 0.5\text{ A}$	400	—	1000		
	$h_{FE} (2)$	$V_{CE} = 2\text{ V}, I_C = 1.6\text{ A}$	200	—	—		
Collector-emitter saturation voltage	$V_{CE (sat)}$	$I_C = 1.6\text{ A}, I_B = 32\text{ mA}$	—	—	0.12	V	
Base-emitter saturation voltage	$V_{BE (sat)}$	$I_C = 1.6\text{ A}, I_B = 32\text{ mA}$	—	—	1.10	V	
Collector output capacitance	$C_{ob}$	$V_{CB} = 10\text{ V}, I_E = 0, f = 1\text{ MHz}$	—	26	—	pF	
Switching time	Rise time	$t_r$	See Figure 1 circuit diagram.			—	ns
	Storage time	$t_{stg}$	$V_{CC} \approx 30\text{ V}, R_L = 19\ \Omega$			—	
	Fall time	$t_f$	$I_{B1} = -I_{B2} = 53.3\text{ mA}$			—	



**Figure 1 Switching Time Test Circuit & Timing Chart**





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